Ivan Davoli

List of Publications by Year in descending order

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331670 330143 1,776 116 21 37 h-index citations g-index papers 117 117 117 1821 docs citations times ranked citing authors all docs

#	Article	IF	CITATIONS
1	Characterization of CdS sputtering deposition on low temperature pulsed electron deposition Cu(In,Ga)Se2 solar cells. Thin Solid Films, 2020, 697, 137833.	1.8	2
2	Nano-indentation mechanical characterizations of solution processed inorganic metal oxide thin films and influence of grain size. AIP Advances, 2020, 10, 105016.	1.3	1
3	Structural Evolution of MoO3 Thin Films Deposited on Copper Substrates upon Annealing: An X-ray Absorption Spectroscopy Study. Condensed Matter, 2019, 4, 41.	1.8	20
4	MoO3 films grown on polycrystalline Cu: Morphological, structural, and electronic properties. Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films, 2019, 37, .	2.1	15
5	Boosting highly transparent and conducting indium zinc oxide thin films through solution combustion synthesis: influence of rapid thermal annealing. Semiconductor Science and Technology, 2018, 33, 105004.	2.0	10
6	Multiscale mechanical characterization of hybrid Ti/PMMA layered materials. Colloids and Surfaces A: Physicochemical and Engineering Aspects, 2017, 532, 244-251.	4.7	13
7	Mechanical characterization of stacked thin films: The cases of aluminum zinc oxide and indium zinc oxide grown by solution and combustion synthesis. Thin Solid Films, 2017, 640, 109-115.	1.8	3
8	Rapid Thermal Annealing for Solution Synthesis of Transparent Conducting Aluminum Zinc Oxide Thin Films. Journal of Electronic Materials, 2017, 46, 6609-6616.	2,2	7
9	Anodization-based process for the fabrication of all niobium nitride Josephson junction structures. Beilstein Journal of Nanotechnology, 2017, 8, 539-546.	2.8	2
10	Atomic Force Microscopy Techniques for Nanomechanical Characterization: A Polymeric Case Study. Jom, 2015, 67, 849-857.	1.9	16
11	Characterization of Thick Film of Copper Electrodeposited for Cryogenic Applications. Journal of the Electrochemical Society, 2014, 161, D540-D545.	2.9	3
12	IRIDE: Interdisciplinary research infrastructure based on dual electron linacs and lasers. Nuclear Instruments and Methods in Physics Research, Section A: Accelerators, Spectrometers, Detectors and Associated Equipment, 2014, 740, 138-146.	1.6	9
13	MOD Derived Pyrochlore Films as Buffer Layer for All-Chemical YBCO Coated Conductors. IEEE Transactions on Applied Superconductivity, 2013, 23, 6600505-6600505.	1.7	15
14	Discoloration of the smalt pigment: experimental studies and ab initio calculations. Journal of Analytical Atomic Spectrometry, 2012, 27, 1941.	3.0	21
15	Oxidation Behavior at the Ni–W and \${m CeO}_{2}\$ Interface With and Without Pd Over Layer. IEEE Transactions on Applied Superconductivity, 2011, 21, 2891-2895.	1.7	1
16	Structural and chemical evolution of propionate based metal–organic precursors for superconducting YBa ₂ Cu ₃ O _{7 â^î Î} epitaxial film growth. Superconductor Science and Technology, 2011, 24, 115008.	3.5	22
17	Electrical and Mechanical Characterization of Coated Conductors Lap Joints. IEEE Transactions on Applied Superconductivity, 2010, 20, 1549-1552.	1.7	29
18	Natural hybrid organic–inorganic photovoltaic devices. Superlattices and Microstructures, 2009, 45, 555-563.	3.1	9

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19	Indentation modulus and hardness of viscoelastic thin films by atomic force microscopy: A case study. Ultramicroscopy, 2009, 109, 1417-1427.	1.9	37
20	Deposition and Characterization of Metal Propionate Derived Epitaxial ${m YBa}_{2}m Cu}_{3}m O}_{7-{m x}}$ Films for Coated Conductor Fabrication. IEEE Transactions on Applied Superconductivity, 2009, 19, 3204-3207.	1.7	15
21	Electron spectroscopy analysis on NbN to grow and characterize NbN/AlN/NbN Josephson junction. Superlattices and Microstructures, 2008, 43, 518-523.	3.1	8
22	Atomic force acoustic microscopy characterization of nanostructured selenium–tin thin films. Superlattices and Microstructures, 2008, 44, 641-649.	3.1	35
23	Characterization of epitaxial YBa2Cu3O7â^îfilms deposited by metal propionate precursor solution. Superconductor Science and Technology, 2008, 21, 125015.	3.5	21
24	A new procedure for the quantitative analysis of extended x-ray absorption fine structure data in total reflection geometry. Review of Scientific Instruments, 2008, 79, 103902.	1.3	16
25	Quantitative measurement of indentation hardness and modulus of compliant materials by atomic force microscopy. Review of Scientific Instruments, 2008, 79, 066105.	1.3	26
26	Electron spectroscopy study in the NbN growth for NbN/AlN interfaces. Surface Science, 2007, 601, 2647-2650.	1.9	15
27	XAS study of a Pt-containing rod-like organometallic polymer. Chemical Physics, 2006, 325, 422-428.	1.9	10
28	Characterization of thermally treated Mo/Si multilayer mirrors with standing wave-assisted EXAFS. Nuclear Instruments & Methods in Physics Research B, 2006, 246, 127-130.	1.4	5
29	Optimization of a NOx gas sensor based on single walled carbon nanotubes. Sensors and Actuators B: Chemical, 2006, 118, 226-231.	7.8	66
30	Electronic Characterization of the SingleWall Carbon Nanotubes a XANES Study. Physica Scripta, 2005, , 717.	2.5	1
31	X-ray absorption and photoelectron spectroscopy studies on graphite and single-walled carbon nanotubes: Oxygen effect. Applied Physics Letters, 2005, 87, 051923.	3.3	53
32	Magnetisation and magnetostriction in Fe/Terfecohan/Fe sandwich films with an extended domain wall formation. Journal of Magnetism and Magnetic Materials, 2004, 272-276, E1597-E1599.	2.3	3
33	Structure of a monolayer of Pd-diethynylbiphenyl deposited on chromium studied by total reflection EXAFS. Sensors and Actuators B: Chemical, 2004, 100, 131-134.	7.8	8
34	$InxGa(1\hat{a}^2x)As$ quantum dots grown on GaAs studied by EXAFS in total reflection mode (ReflEXAFS). Nuclear Instruments & Methods in Physics Research B, 2003, 200, 85-89.	1.4	8
35	Probing the initial stages of solid-state reactions by total reflection EXAFS (reflEXAFS). Nuclear Instruments & Methods in Physics Research B, 2003, 200, 421-424.	1.4	13
36	The ReflEXAFS station at the GILDA beamline (BM08) of ESRF. Journal of Synchrotron Radiation, 2003, 10, 260-264.	2.4	53

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37	Do we have a probe for the initial stages of solid state reactions?. Physical Chemistry Chemical Physics, 2003, 5, 2244-2247.	2.8	13
38	The effect of Sb surfactant on the growth of (GenSim)p layers on Si: a reflEXAFS study. Surface Science, 2002, 518, 183-191.	1.9	9
39	THE VALENCE AND SPECIATION OF SULFUR IN GLASSES BY X-RAY ABSORPTION SPECTROSCOPY. Canadian Mineralogist, 2001, 39, 331-339.	1.0	58
40	Temperature modification of the Nb oxidation at the Nb/Al interface studied by reflEXAFS. Surface Science, 2000, 468, 77-84.	1.9	20
41	Local structural investigation of silicon surfaces by electron scattering. Nuovo Cimento Della Societa Italiana Di Fisica D - Condensed Matter, Atomic, Molecular and Chemical Physics, Biophysics, 1998, 20, 991-998.	0.4	0
42	Evidence for the suppression of incident beam effects in Auger electron diffraction. Surface Science, 1998, 396, 221-226.	1.9	2
43	Surfactant-Mediated Growth of Ge/Si(001) Interface Studied by XPD. Surface Review and Letters, 1998, 05, 157-161.	1.1	6
44	Low kinetic energy AED: a tool for the study of Ge epitaxial layers grown on Sb-terminated Si(111) surface. Journal of Electron Spectroscopy and Related Phenomena, 1997, 83, 137-142.	1.7	3
45	XPD study of atomic intermixing at the Ge/Si(001) interface. Applied Surface Science, 1996, 102, 102-106.	6.1	7
46	Interface ordering inSim/Genmonolayer superlattices: A photoluminescence study. Physical Review B, 1996, 53, 1030-1033.	3.2	4
47	X-ray photoelectron-diffraction study of intermixing and morphology at the Ge/Si(001) and Ge/Sb/Si(001) interface. Physical Review B, 1996, 54, 8882-8891.	3.2	39
48	Structural surface investigation with low energy backscattered electrons. Journal of Electron Spectroscopy and Related Phenomena, 1995, 76, 29-36.	1.7	2
49	Incident beam effects in AED (Auger Electron Diffraction): the case of Cu(001). Journal of Electron Spectroscopy and Related Phenomena, 1995, 76, 493-497.	1.7	4
50	An experimental study of an interface reaction at the practical Pd/Si interface by XPS. Vacuum, 1995, 46, 139-142.	3.5	10
51	Theoretical analysis of x-ray-absorption spectra at the siliconKandL2,3edges of crystalline and amorphousSiO2. Physical Review B, 1995, 52, 10014-10020.	3.2	31
52	Auger-electron diffraction in the low kinetic-energy range: The Si(111)7×7 surface reconstruction and Ge/Si interface formation. Physical Review B, 1995, 52, 1806-1815.	3.2	25
53	Inelastic processes versus diffraction effects: Polar-angle energy-loss spectra of the graphiteKedge. Physical Review B, 1995, 52, 17091-17098.	3.2	9
54	Local structure of diamond films: Auger and EELFS investigation. Surface Science, 1995, 331-333, 1050-1055.	1.9	5

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55	High-temperature oxidation of one- and two-component metallic systems studied by in-situ X-ray absorption spectroscopy. Journal of Alloys and Compounds, 1995, 218, 237-243.	5.5	4
56	The initial adsorption of oxygen on the Si(111)7 \tilde{A} — 7 surface at 150 K. Applied Surface Science, 1994, 78, 293-297.	6.1	4
57	The study of MgO(001) surfaces by photoelectron diffraction. Surface Science, 1994, 314, 145-156.	1.9	25
58	Angular dependence of the EXFAS (extended fine Auger structure) in MgO(100) surfaces: short-range order versus diffraction effects. Surface Science, 1994, 306, 144-154.	1.9	17
59	An experimental study of interface reaction at the practical Pt/Si interface by XPS. Vacuum, 1993, 44, 1189-1192.	3.5	2
60	Low-temperature mechanical energy dissipation phenomena in lanthanum superconductors. Physica C: Superconductivity and Its Applications, 1993, 207, 300-306.	1.2	12
61	Dissociative chemisorption of water on the $Si(111)$ 7*7 surface studied at 150 K by X-ray photoelectron spectroscopy and energy loss spectroscopy. Journal of Physics Condensed Matter, 1992, 4, 5855-5862.	1.8	3
62	Mechanical energy dissipation phenomena in 1-2-4 yttrium superconductors. Journal of Physics Condensed Matter, 1992, 4, L115-L117.	1.8	1
63	High-temperature oxidation technique by in situ characterization of oxide growth. Journal of Materials Chemistry, 1992, 2, 745.	6.7	2
64	Structure of densified vitreous silica: Silicon and oxygen XANES spectra and multiple scattering calculations. Physics and Chemistry of Minerals, 1992, 19, 171.	0.8	53
65	Extended energy loss fine structure technique: an analytical tool for surface and bulk characterization. Vacuum, 1992, 43, 393-396.	3.5	0
66	Some aspects of mechanical energy dissipation phenomena in yttrium superconductors Solid State Communications, 1992, 83, 793-797.	1.9	6
67	Magnetic properties of diluted (Zn1-xMnx)3As2 solutions. Solid State Communications, 1992, 84, 531-535.	1.9	5
68	Enhanced backscattering of light in a polycrystalline organic film. Thin Solid Films, 1992, 207, 4-5.	1.8	2
69	Urbach effects in the kinetics of core holes for excitation of cross-luminescence. Journal of Luminescence, 1992, 51, 275-282.	3.1	15
70	The oxygen adsorption and the initial oxidation of indium. Applied Surface Science, 1992, 59, 195-199.	6.1	15
71	XPS and AES studies of the interface reaction at the practical Pt/InP interface. Applied Surface Science, 1992, 62, 249-254.	6.1	2
72	Exchange interaction and the g-factor for 2D-electrons in heterostructures GaAs-Ga1â^'xAlxAs. Solid State Communications, 1991, 77, 961-965.	1.9	2

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73	Determining Fe-Mg Intersite Distribution in natural and heated Orthopyroxenes by Synchrotron X-ray Absorption Spectroscopy. Rendiconti Lincei, 1991, 2, 379-387.	2.2	4
74	Electrical Conductivity of NH2-Substituted Ni(II)-Phthalocyanine. Physica Status Solidi A, 1991, 125, 597-607.	1.7	15
75	Variations of internal friction in YBa2Cu3Ox superconductors. Journal of Materials Science, 1990, 25, 2125-2128.	3.7	1
76	Some properties of thin layers of silica containing carbon and iron oxides prepared by the sol-gel method. Journal of Materials Science, 1990, 25, 2569-2572.	3.7	4
77	Internal friction in high Tc iron doped 1-2-3 yttrium ceramic superconductors. Solid State Communications, 1990, 74, 595-598.	1.9	19
78	Relaxation phenomena in 1-2-3 high Tc superconductors. Solid State Communications, 1990, 75, 789-790.	1.9	7
79	Elastic constant and internal friction in YBa2Cu3Ox single crystal. Solid State Communications, 1990, 76, 357-360.	1.9	7
80	Drift resonance in the quantum hall effect. Solid State Communications, 1990, 73, 583-588.	1.9	7
81	Optical Constants of Tetracene Single Crystal within the First Absorption Band. Molecular Crystals and Liquid Crystals Incorporating Nonlinear Optics, 1989, 166, 233-244.	0.3	2
82	Superconducting and anelastic effects in Pb-doped BiSrCaCuO ceramics. Physica C: Superconductivity and Its Applications, 1989, 160, 25-29.	1.2	7
83	Xanes studies of bis-1-oxopyridine-2-thiolato Pt(II) complexes. Chemical Physics Letters, 1989, 155, 599-602.	2.6	O
84	Palladium L3 absorption edge of PdH0.6 films: Evidence for hydrogen induced unoccupied states. Solid State Communications, 1989, 71, 383-390.	1.9	18
85	Anelastic effects in CuO. Solid State Communications, 1989, 72, 97-99.	1.9	9
86	Thermoluminescence Study of Charge Traps in Polycrystalline Layers of Phenanthrene. Physica Status Solidi (B): Basic Research, 1988, 149, 363-370.	1.5	4
87	X-ray absorption spectroscopy in compressed vitreous silica and vanadium pentoxyde gel. Journal of Non-Crystalline Solids, 1987, 95-96, 327-333.	3.1	1
88	Local structure of nickel oxide grown at high temperatures in ceramic electrolyte cells. Journal of the Chemical Society Faraday Transactions I, 1987, 83, 289.	1.0	6
89	Xanes analysis on pyroxenes with different ca concentration in M2 site. Physics and Chemistry of Minerals, 1987, 14, 21-25.	0.8	16

Partial density of unoccupied states and L2,3-x-ray absorption spectrum of bulk silicon and of the Si(1 1) Tj ETQq0 Q.9 rgBT /Qyerlock 10

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91	Asymmetries in the optical properties of vacuum-deposited organic films illuminated at the substrate and non-substrate surfaces. Thin Solid Films, 1987, 146, 115-132.	1.8	19
92	The Interatomic Intermediate Valence State of Insulating Correlated Oxides CeO2, PrO2 and TbO2. , 1987, , 243-251.		2
93	EXAFS and XANES joint analyses for semiconducting vanadium phosphate glasses. Journal of Non-Crystalline Solids, 1986, 80, 175-180.	3.1	18
94	Internal friction in vanadium-phosphate glasses doped with Na2O. Journal of Non-Crystalline Solids, 1986, 80, 263-268.	3.1	0
95	Three particle correlation function of metal ions in tetrahedral coordination determined by XANES. Solid State Communications, 1986, 58, 595-599.	1.9	38
96	Local electronic structures at selected sites of intermetallic perovskites Mn3MeX (Me=divalent metal,) Tj ETQq0 Chemical Physics, Biophysics, 1986, 7, 493-505.	0 0 rgBT / 0.4	Overlock 10 9
97	Local structure determination by surface XANES spectroscopy of SiO2 amorphous layer on NiO. Journal of Materials Science Letters, 1986, 5, 441-442.	0.5	O
98	Multielectron configurations in the x-ray-absorption near-edge structure of NiO at the oxygenKthreshold. Physical Review B, 1986, 33, 2979-2982.	3.2	85
99	Multiple-scattering regime and higher-order correlations in x-ray-absorption spectra of liquid solutions. Physical Review B, 1986, 34, 5774-5781.	3.2	196
100	XANES (x ray absorption near edge structure): A new probe of higher order correlation function in amorphous semiconductors. Journal of Non-Crystalline Solids, 1985, 77-78, 1325-1328.	3.1	6
101	Localization mixing and / or hybridization in intermetallic compounds RPd3 (R = La, Ce, Pr, Nd, Sm) by xanes. Journal of Magnetism and Magnetic Materials, 1985, 47-48, 206-208.	2.3	7
102	Determination of mixing of 4f-ligand orbitals in Ce(SO4)2 by Xanes is Ce(SO4)2 a mixed valent insulating system?. Journal of Magnetism and Magnetic Materials, 1985, 47-48, 209-211.	2.3	39
103	Experimental evidence for the "shake-down―peak in LIII (and LII)-xanes of light rare earth intermetallics. Solid State Communications, 1984, 49, 409-415.	1.9	33
104	XANES of Palladium Rare Earth Intermetallics (RPd3): Determination of Hybridization and Mixing of 4f-Orbitals. Springer Proceedings in Physics, 1984, , 52-54.	0.2	1
105	Role of multielectron excitations in the L3 XANES of Pd. Solid State Communications, 1983, 46, 367-370.	1.9	21
106	The character of metal-insulator phase transition in V2O3 from the plasmon behaviour. Solid State Communications, 1983, 48, 471-474.	1.9	4
107	The local electronic structure of PdO crystal and PdO catalyst supported on SiO2 and \hat{I}^3 -Al2O3 from L3 and L1 x-ray absorption Pd edge in XANES spectra. Solid State Communications, 1983, 48, 475-478.	1.9	21
108	Thermoreflectance study of polydiacetylene-bis (toluene sulphonate) single crystal (PDA-TS). Journal of Physics C: Solid State Physics, 1983, 16, 2165-2176.	1.5	2

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109	XANES Determination of V-Mixed Valence State in (V2O5) x (P2O5)100â^'x Binary Oxide Glasses. Springer Series in Chemical Physics, 1983, , 162-164.	0.2	4
110	High-Resolution Analysis of the L2,3 White Lines of Pd. Springer Series in Chemical Physics, 1983, , 177-179.	0.2	0
111	Sexafs study of the natural oxide on iron surface detected by total photoelectron yield. Solid State Communications, 1982, 44, 1585-1588.	1.9	6
112	Internal friction and electrical conductivity in iron?vanadium?phosphate glasses. Journal of Materials Science Letters, 1982, 1, 264-267.	0.5	3
113	Intermediate valence and near-edge structure in the x-ray absorption spectrum of CePd3, $\hat{l}^3\hat{a}^{-1}$ Ce, and CeCu2Si2. Physical Review B, 1981, 24, 6139-6142.	3.2	18
114	Giant Raman scattering and luminescence by molecules adsorbed on Ag and Au metal island films. Surface Science, 1980, 101, 363-366.	1.9	74
115	Shift of electronic states at L in α-phase Cu-Zn and Cu-Al alloys. Journal of Physics F: Metal Physics, 1979, 9, 2275-2285.	1.6	9
116	Shift of electronic states at L in \$alpha\$-phase Cu-Zn and Cu-Al alloys. Journal of Physics F: Metal Physics, 1979, 9, 2523-2523.	1.6	0